

Application/Control No.	Applicant(s)/Patent under Reexamination TAUPIER ET AL.	
10/624,932		
Examiner	Art Unit	
Christopher J. Nichols, Ph.D.	1647	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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